

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TSUCHIYA ET AL.	
		Examiner Jennifer M. Kennedy	Art Unit 2812	Page 1 of 1

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	B	US-6,136,680	10-2000	Lai et al.	438/597
	C	US-2003/0166337	09-2003	Wang et al.	438/689
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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